

64K SPITM Bus Serial EEPROM

Device Selection Table

Part Number	Vcc Range	Max Clock Frequency	Temp Ranges
25AA640	1.8-5.5V	1 MHz	I
25LC640	2.5-5.5V	2 MHz	I
25LC640	4.5-5.5V	3/2.5 MHz	I, E

Features

- Low power CMOS technology
 - Write current: 3 mA typical
 - Read current: 500 µA typical
 - Standby current: 500 nA typical
- 8192 x 8 bit organization
- 32 byte page
- Write cycle time: 5 ms max.
- Self-timed ERASE and WRITE cycles
- · Block write protection
 - Protect none, 1/4, 1/2 or all of array
- Built-in write protection
 - Power on/off data protection circuitry
 - Write enable latch
 - Write protect pin
- Sequential read
- High reliability
 - Data retention: > 200 years
 - ESD protection: > 4000V
- 8-pin PDIP, SOIC and TSSOP packages
- Temperature ranges supported:
 - Industrial (I): -40°C to +85°C
 - Automotive (E): -40°C to +125°C

Package Types

PDIP/SOIC TSSOP 8 Vcc 8 SCK 25XX640 Vcc 🗗 2 7占SI 25XX640 SOL 2 7 HOLD CS 🗗 3 6占Vss WP [3 6 SCK SO 🗗 4 5 ЪWР Vss 🗖 4 5 🗆 SI

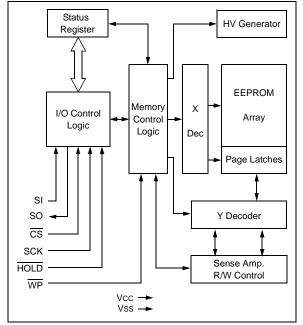
*25XX640 is used in this document as a generic part number for the 25AA640/25LC640 devices.

Description

The Microchip Technology Inc. 25AA640/25LC640 $(25XX640^*)$ is a 64K bit Serial Electrically Erasable PROM [EEPROM]. The memory is accessed via a simple Serial Peripheral Interface (SPI) compatible serial bus. The bus signals required are a clock input (SCK) plus separate data in (SI) and data out (SO) lines. Access to the device is controlled through a chip select $\overline{(CS)}$ input.

Communication to the device can be paused via the hold pin (HOLD). While the device is paused, transitions on its inputs will be ignored, with the exception of chip select, allowing the host to service higher priority interrupts.

Block Diagram



1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings†

Vcc	7.0V
All inputs and outputs w.r.t. Vss	-0.6V to Vcc+1.0V
Storage temperature	65°C to 150°C
Ambient temperature under bias	65°C to 125°C
Soldering temperature of leads (10 seconds)	+300°C
ESD protection on all pins	4 kV

† NOTICE: Stresses above those listed under 'Maximum ratings' may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for an extended period of time may affect device reliability.

DC Char	acteristics		Industrial (I): Automotive (E			-85°C Vcc = 1.8V to 5.5V -125°C Vcc = 4.5V to 5.5V
Param. No.	Sym	Characteristics	Min	Max	Units	Conditions
D1	ViH1	High level input voltage	2.0	Vcc+1	V	Vcc ≥ 2.7V (Note)
D2	VIH2		0.7 Vcc	Vcc+1	V	Vcc< 2.7V (Note)
D3	VIL1	Low level input voltage	-0.3	0.8	V	Vcc ≥ 2.7V (Note)
D4	VIL2		-0.3	0.2 Vcc	V	Vcc < 2.7V (Note)
D5	Vol	Low level output voltage	_	0.4	V	IOL = 2.1 mA
			_	0.2	V	IOL = 1.0 mA, VCC = < 2.5V
D6	Voн	High level output voltage	Vcc -0.5	—	V	ΙΟΗ = -400 μΑ
D7	LI	Input leakage current	-10	10	μΑ	\overline{CS} = VCC, VIN = VSS TO VCC
D8	Ilo	Output leakage current	-10	10	μΑ	CS = Vcc, Vout = Vss to Vcc
D9	CINT	Internal Capacitance (all inputs and outputs)	—	7	pF	TAMB = 25°C, CLK = 1.0 MHz, Vcc = 5.0V (Note)
D10	ICC Read	Operating Current		1 500	mA μA	Vcc = 5.5V; FcLk = 3.0 MHz; SO = Open Vcc = 2.5V; FcLk = 2.0 MHz; SO = Open
D11	ICC Write	1	_	5	mA	Vcc = 5.5V
			—	3	mA	Vcc = 2.5V
D12	Iccs	Standby Current	—	5	μA	\overline{CS} = Vcc = 5.5V, Inputs tied to Vcc or Vss
			—	1	μA	CS = VCC = 2.5V, Inputs tied to VCC or VS

1.1 DC Characteristics

Note: This parameter is periodically sampled and not 100% tested.

1.2 AC Characteristics

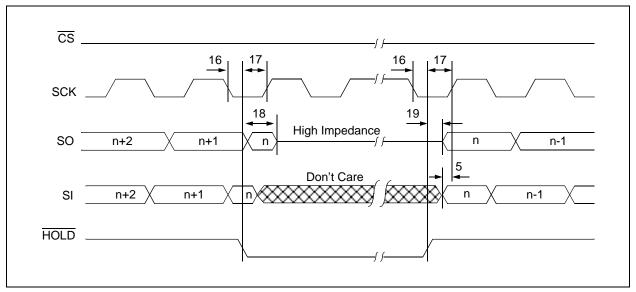
AC Chara	cteristics		Industrial (I): Automotive (TAMB = -4 E): TAMB = -4	40°C to +8 40°C to +12	
Param. No.	Sym	Characteristic	Min	Max	Units	Conditions
1	FCLK	Clock Frequency	—	3	MHz	Vcc = 4.5V to 5.5V (Note 2)
			—	2	MHz	$V_{CC} = 2.5V$ to 5.5V
0	Teee			1	MHz	Vcc = 1.8V to 5.5V
2	Tcss	CS Setup Time	100 250	_	ns ns	Vcc = 4.5V to 5.5V Vcc = 2.5V to 5.5V
			500	_	ns	VCC = 1.8V to 5.5V
3	Тсѕн	CS Hold Time	150	_	ns	VCC = 4.5V to 5.5V
			250	_	ns	VCC = 2.5V to 5.5V
			475		ns	Vcc = 1.8V to 5.5V
4	TCSD	CS Disable Time	500	—	ns	
5	Tsu	Data Setup Time	30	—	ns	VCC = 4.5V to 5.5V
			50	—	ns	VCC = 2.5V to 5.5V
			50		ns	Vcc = 1.8V to 5.5V
6	THD	Data Hold Time	50	-	ns	$V_{CC} = 4.5V$ to 5.5V
			100 100	_	ns ns	Vcc = 2.5V to 5.5V Vcc = 1.8V to 5.5V
7	TR	CLK Rise Time	-	2		(Note 1)
	TF	CLK Fall Time		2	μs	
8			-	2	μs	(Note 1)
9	Тні	Clock High Time	150 230	_	ns ns	Vcc = 4.5V to 5.5V Vcc = 2.5V to 5.5V
			475		ns	VCC = 2.5V 10 5.5V VCC = 1.8V to 5.5V
10	TLO	Clock Low Time	150	_	ns	Vcc = 4.5V to 5.5V
10	TLO		230	_	ns	VCC = 2.5V to 5.5V
			475	_	ns	VCC = 1.8V to 5.5V
11	TCLD	Clock Delay Time	50	_	ns	
12	TCLE	Clock Enable Time	50	—	ns	
13	Τv	Output Valid from	_	150	ns	VCC = 4.5V to 5.5V
		Clock Low	—	230	ns	Vcc = 2.5V to 5.5V
				475	ns	Vcc = 1.8V to 5.5V
14	Тно	Output Hold Time	0		ns	(Note 1)
15	TDIS	Output Disable Time	—	200	ns	Vcc = 4.5V to 5.5V (Note 1)
			-	250 500	ns ns	Vcc = 2.5V to 5.5V (Note 1) Vcc = 1.8V to 5.5V (Note 1)
16	Tuo		100	500		
16	THS	HOLD Setup Time	100 100	_	ns ns	Vcc = 4.5V to 5.5V Vcc = 2.5V to 5.5V
			200	_	ns	VCC = 1.8V to 5.5V
17	Тнн	HOLD Hold Time	100	_	ns	Vcc = 4.5V to 5.5V
			100	—	ns	VCC = 2.5V to 5.5V
			200	—	ns	Vcc = 1.8V to 5.5V
18	THZ	HOLD Low to Output	100	_	ns	Vcc = 4.5V to 5.5V (Note 1)
		High-Z	150	_	ns	Vcc = 2.5V to 5.5V (Note 1)
			200		ns	Vcc = 1.8V to 5.5V (Note 1)
19	THV	HOLD High to Output	100	—	ns	$V_{CC} = 4.5V$ to 5.5V
		Valid	150 200		ns ns	Vcc = 2.5V to 5.5V Vcc = 1.8V to 5.5V
20	Twc	Internal Write Cycle	200	5		1.00 10 0.00
20	TWC	Internal Write Cycle Time		Э	ms	
21	_	Endurance	100 k	<u> </u>	E/W	(Note 3)
21				1	Cycles	(

Note 1: This parameter is periodically sampled and not 100% tested.

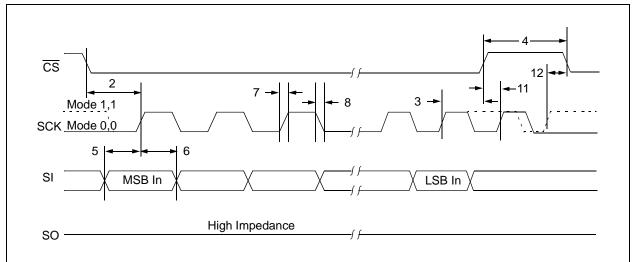
2: FCLK max. = 2.5 MHz for TAMB > 85°C.

3: This parameter is not tested but established by characterization. For endurance estimates in a specific application, please consult the Total Endurance Model which can be obtained on our website.

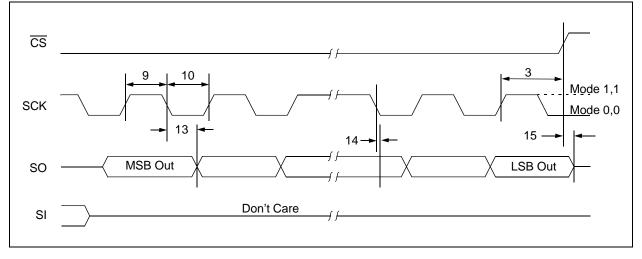
FIGURE 1-1: HOLD TIMING











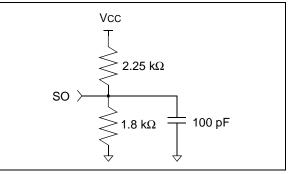
1.3 AC Test Conditions

AC Waveform:					
(Note 1)					
(Note 2)					
Timing Measurement Reference Level					
0.5 VCC					
0.5 Vcc					

Note 1: For $VCC \le 4.0V$

2: For Vcc > 4.0V

FIGURE 1-4: AC TEST CIRCUIT



2.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 2-1.

Name	PDIP	SOIC	TSSOP	Description
CS	1	1	3	Chip Select Input
SO	2	2	4	Serial Data Output
WP	3	3	5	Write Protect Pin
Vss	4	4	6	Ground
SI	5	5	7	Serial Data Input
SCK	6	6	8	Serial Clock Input
HOLD	7	7	1	Hold Input
Vcc	8	8	2	Supply Voltage

TABLE 2-1: PIN FUNCTION TABLE

2.1 Chip Select (CS)

A low level on this pin selects the device. A high level deselects the device and forces it into standby mode. However, a programming cycle which is already initiated or in progress will be completed, regardless of the \overline{CS} input signal. If \overline{CS} is brought high during a program cycle, the device will go into standby mode when the programming cycle is complete. When the device is deselected, SO goes to the high impedance state, allowing multiple parts to share the same SPI bus. A low to high transition on \overline{CS} after a valid write sequence initiates an internal write cycle. After power-up, a high to low transition on \overline{CS} is required prior to any sequence being initiated.

2.2 Serial Output (SO)

The SO pin is used to transfer data out of the 25XX640. During a read cycle, data is shifted out on this pin after the falling edge of the serial clock.

2.3 Write Protect (WP)

This pin is used in conjunction with the WPEN bit in the status register to prohibit writes to the non-volatile bits in the status register. When \overline{WP} is low and WPEN is high, writing to the non-volatile bits in the status register is disabled. All other operations function normally. When \overline{WP} is high, all functions, including writes to the non-volatile bits in the status register operate normally. If the WPEN bit is set, \overline{WP} low during a status register write sequence will disable writing to the status register. If an internal write cycle has already begun, \overline{WP} going low will have no effect on the write.

The $\overline{\text{WP}}$ pin function is blocked when the WPEN bit in the status register is low. This allows the user to install the 25AA640/25LC640 in a system with $\overline{\text{WP}}$ pin grounded and still be able to write to the status register. The $\overline{\text{WP}}$ pin functions will be enabled when the WPEN bit is set high.

2.4 Serial Input (SI)

The SI pin is used to transfer data into the device. It receives instructions, addresses, and data. Data is latched on the rising edge of the serial clock.

2.5 Serial Clock (SCK)

The SCK is used to synchronize the communication between a master and the 25XX640. Instructions, addresses, or data present on the SI pin are latched on the rising edge of the clock input, while data on the SO pin is updated after the falling edge of the clock input.

2.6 Hold (HOLD)

The HOLD pin is used to suspend transmission to the 25XX640 while in the middle of a serial sequence without having to re-transmit the entire sequence over again. It must be held high any time this function is not being used. Once the device is selected and a serial sequence is underway, the HOLD pin may be pulled low to pause further serial communication without resetting the serial sequence. The HOLD pin must be brought low while SCK is low, otherwise the HOLD function will not be invoked until the next SCK high to low transition. The 25XX640 must remain selected during this sequence. The SI, SCK, and SO pins are in a high impedance state during the time the device is paused and transitions on these pins will be ignored. To resume serial communication, HOLD must be brought high while the SCK pin is low, otherwise serial communication will not resume. Lowering the HOLD line at any time will tri-state the SO line.

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3.0 FUNCTIONAL DESCRIPTION

3.1 **Principles Of Operation**

The 25XX640 is a 8192 byte Serial EEPROM designed to interface directly with the Serial Peripheral Interface (SPI) port of many of today's popular microcontroller families, including Microchip's PIC16C6X/7X microcontrollers. It may also interface with microcontrollers that do not have a built-in SPI port by using discrete I/O lines programmed properly with the software.

The 25XX640 contains an 8-bit instruction register. The device is accessed via the SI pin, with data being clocked in on the rising edge of SCK. The \overline{CS} pin must be low and the HOLD pin must be high for the entire operation.

Table 3-1 contains a list of the possible instruction bytes and format for device operation. All instructions, addresses, and data are transferred MSB first, LSB last.

Data is sampled on the first rising edge of SCK after \overline{CS} goes low. If the clock line is shared with other peripheral devices on the SPI bus, the user can assert the HOLD input and place the 25XX640 in 'HOLD' mode. After releasing the HOLD pin, operation will resume from the point when the HOLD was asserted.

3.2 Read Sequence

The device is selected by pulling $\overline{\text{CS}}$ low. The 8-bit read instruction is transmitted to the 25XX640 followed by the 16-bit address with the three MSB's of the address being don't care bits. After the correct read instruction and address are sent, the data stored in the memory at the selected address is shifted out on the SO pin. The data stored in the memory at the next address can be read sequentially by continuing to provide clock pulses. The internal address pointer is automatically incremented to the next higher address after each byte of data is shifted out. When the highest address is reached (1FFFh), the address counter rolls over to address 0000h allowing the read cycle to be continued indefinitely. The read operation is terminated by raising the $\overline{\text{CS}}$ pin (Figure 3-1).

3.3 Write Sequence

Prior to any attempt to write data to the 25XX640 array or status register, the write enable latch must be set by issuing the WREN instruction (Figure 3-4). This is done by setting \overline{CS} low and then clocking out the proper instruction into the 25XX640. After all eight bits of the instruction are transmitted, the \overline{CS} must be brought high to set the write enable latch. If the write operation is initiated immediately after the WREN instruction without \overline{CS} being brought high, the data will not be written to the array because the write enable latch will not have been properly set.

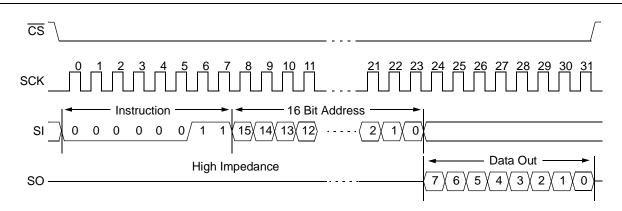
Once the write enable latch is set, the user may proceed by setting the \overline{CS} low, issuing a write instruction, followed by the address, and then the data to be written. Up to 32 bytes of data can be sent to the 25XX640 before a write cycle is necessary. The only restriction is that all of the bytes must reside in the same page. A page address begins with XXX0 0000 and ends with XXX1 1111. If the internal address counter reaches XXX1 1111 and the clock continues, the counter will roll back to the first address of the page and overwrite any data in the page that may have been written.

For the data to be actually written to the array, the \overline{CS} must be brought high after the least significant bit (D0) of the nth data byte has been clocked in. If \overline{CS} is brought high at any other time, the write operation will not be completed. Refer to Figure 3-2 and Figure 3-3 for more detailed illustrations on the byte write sequence and the page write sequence respectively. While the write is in progress, the status register may be read to check the status of the WPEN, WIP, WEL, BP1, and BP0 bits (Figure 3-6). A read attempt of a memory array location will not be possible during a write cycle. When the write cycle is completed, the write enable latch is reset.

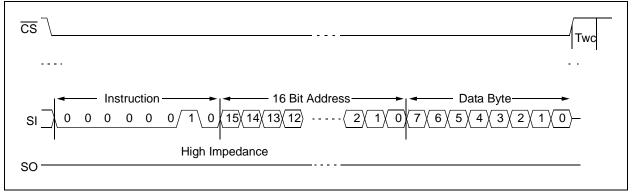
Instruction Name	Instruction Format	Description
READ	0000 0011	Read data from memory array beginning at selected address
WRITE	0000 0010	Write data to memory array beginning at selected address
WREN	0000 0110	Set the write enable latch (enable write operations)
WRDI	0000 0100	Reset the write enable latch (disable write operations)
RDSR	0000 0101	Read status register
WRSR	0000 0001	Write status register

TABLE 3-1: INSTRUCTION SET

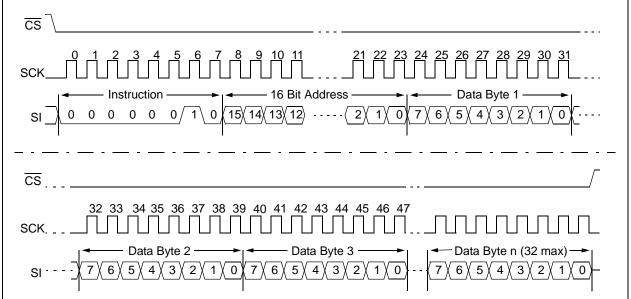












3.4 Write Enable (WREN) and Write Disable (WRDI)

The 25XX640 contains a write enable latch. See Table 3-3 for the Write Protect Functionality Matrix. This latch must be set before any write operation will be completed internally. The WREN instruction will set the latch, and the WRDI will reset the latch.

The following is a list of conditions under which the write enable latch will be reset:

- Power-up
- WRDI instruction successfully executed
- WRSR instruction successfully executed
- WRITE instruction successfully executed

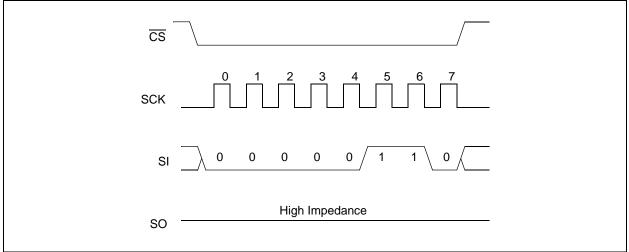


FIGURE 3-5: WRITE DISABLE SEQUENCE

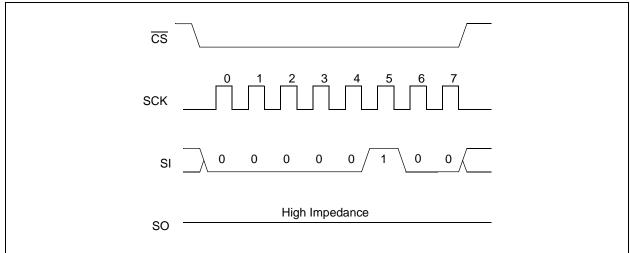


FIGURE 3-4: WRITE ENABLE SEQUENCE

3.5 Read Status Register (RDSR)

The Read Status Register (RDSR) instruction provides access to the status register. The status register may be read at any time, even during a write cycle. The status register is formatted as follows:

7	6	5	4	3	2	1	0
WPEN	Х	Х	Х	BP1	BP0	WEL	WIP

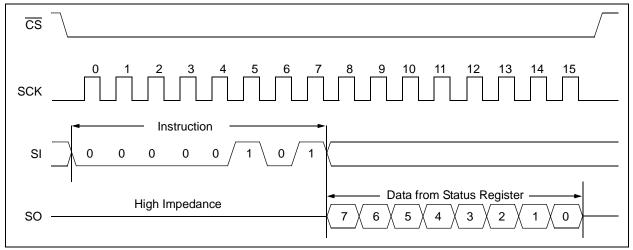
The **Write-In-Process (WIP)** bit indicates whether the 25XX640 is busy with a write operation. When set to a '1', a write is in progress, when set to a '0', no write is in progress. This bit is read only.

The **Write Enable Latch (WEL)** bit indicates the status of the write enable latch. When set to a '1', the latch allows writes to the array and status register, when set to a '0', the latch prohibits writes to the array and status register. The state of this bit can always be updated via the WREN or WRDI commands regardless of the state of write protection on the status register. This bit is read only.

The **Block Protection (BP0 and BP1)** bits indicate which blocks are currently write protected. These bits are set by the user issuing the WRSR instruction. These bits are non-volatile.

See Figure 3-6 for RDSR timing sequence.





3.6 Write Status Register (WRSR)

The Write Status Register (WRSR) instruction allows the user to select one of four levels of protection for the array by writing to the appropriate bits in the status register. The array is divided up into four segments. The user has the ability to write protect none, one, two, or all four of the segments of the array. The partitioning is controlled as shown in Table 3-2.

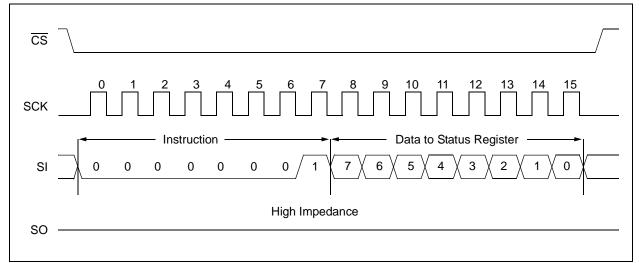
The **Write Protect Enable (WPEN)** bit is a non-volatile bit that is available as an enable bit for the WP pin. The Write Protect (WP) pin and the Write Protect Enable (WPEN) bit in the status register control the programmable hardware write protect feature. Hardware write protection is enabled when WP pin is low and the WPEN bit is high. Hardware write protection is disabled when either the WP pin is high or the WPEN bit is low. When the chip is hardware write protected, only writes to non-volatile bits in the status register are disabled. See Table 3-3 for a matrix of functionality on the WPEN bit.

See Figure 3-7 for WRSR timing sequence.

TABLE 3-2: ARRAY PROTECTION

BP1	BP0	Array Addresses Write Protected
0	0	none
0	1	upper 1/4 (1800h - 1FFFh)
1	0	upper 1/2 (1000h - 1FFFh)
1	1	all (0000h - 1FFFh)

FIGURE 3-7: WRITE STATUS REGISTER TIMING SEQUENCE



3.7 Data Protection

The following protection has been implemented to prevent inadvertent writes to the array:

- The write enable latch is reset on power-up
- A write enable instruction must be issued to set the write enable latch
- After a byte write, page write, or status register write, the write enable latch is reset
- CS must be set high after the proper number of clock cycles to start an internal write cycle
- Access to the array during an internal write cycle is ignored and programming is continued

3.8 Power-On-State

The 25XX640 powers on in the following state:

- The device is in low power standby mode ($\overline{CS} = 1$)
- The write enable latch is reset
- SO is in high impedance state
- A high to low transition on CS is required to enter the active state

TABLE 3-3		FROILOI	I UNCTIONALIT I MA		
WPEN	WP	WEL	Protected Blocks	Unprotected Blocks	Status Register
Х	Х	0	Protected	Protected	Protected
0	Х	1	Protected	Writable	Writable
1	Low	1	Protected	Writable	Protected
Х	High	1	Protected	Writable	Writable

TABLE 3-3: WRITE PROTECT FUNCTIONALITY MATRIX

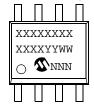
4.0 PACKAGING INFORMATION

4.1 Package Marking Information



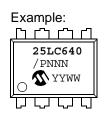


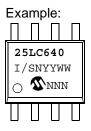
8-Lead SOIC (150 mil)



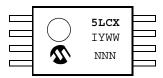
8-Lead TSSOP







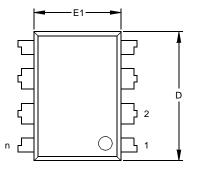
Example:

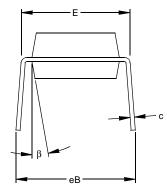


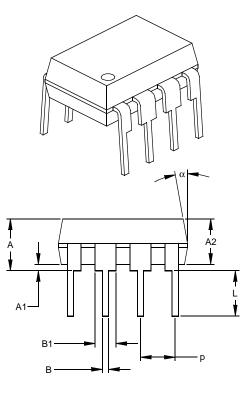
Legend	I: XXX YY WW NNN	Customer specific information* Year code (last 2 digits of calendar year) Week code (week of January 1 is week '01') Alphanumeric traceability code
Note:	be carried	nt the full Microchip part number cannot be marked on one line, it will over to the next line thus limiting the number of available characters er specific information.

* Standard marking consists of Microchip part number, year code, week code, traceability code (facility code, mask rev#, and assembly code). For marking beyond this, certain price adders apply. Please check with your Microchip Sales Office.

8-Lead Plastic Dual In-line (P) – 300 mil (PDIP)







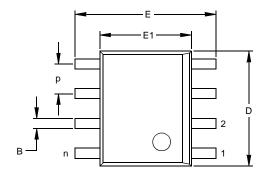
	Units	Inits INCHES*			N	1ILLIMETERS	
Dimens	ion Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		8			8	
Pitch	р		.100			2.54	
Top to Seating Plane	Α	.140	.155	.170	3.56	3.94	4.32
Molded Package Thickness	A2	.115	.130	.145	2.92	3.30	3.68
Base to Seating Plane	A1	.015			0.38		
Shoulder to Shoulder Width	E	.300	.313	.325	7.62	7.94	8.26
Molded Package Width	E1	.240	.250	.260	6.10	6.35	6.60
Overall Length	D	.360	.373	.385	9.14	9.46	9.78
Tip to Seating Plane	L	.125	.130	.135	3.18	3.30	3.43
Lead Thickness	С	.008	.012	.015	0.20	0.29	0.38
Upper Lead Width	B1	.045	.058	.070	1.14	1.46	1.78
Lower Lead Width	В	.014	.018	.022	0.36	0.46	0.56
Overall Row Spacing	§ eB	.310	.370	.430	7.87	9.40	10.92
Mold Draft Angle Top	α	5	10	15	5	10	15
Mold Draft Angle Bottom	β	5	10	15	5	10	15

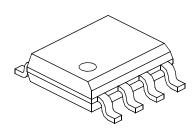
* Controlling Parameter § Significant Characteristic

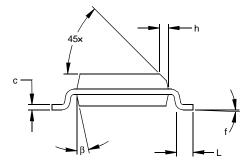
Notes:

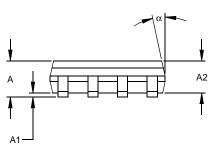
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010" (0.254mm) per side. JEDEC Equivalent: MS-001 Drawing No. C04-018

8-Lead Plastic Small Outline (SN) - Narrow, 150 mil (SOIC)









	Units		INCHES*		Ν	IILLIMETERS	
Dimensio	n Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		8			8	
Pitch	р		.050			1.27	
Overall Height	А	.053	.061	.069	1.35	1.55	1.75
Molded Package Thickness	A2	.052	.056	.061	1.32	1.42	1.55
Standoff §	A1	.004	.007	.010	0.10	0.18	0.25
Overall Width	Е	.228	.237	.244	5.79	6.02	6.20
Molded Package Width	E1	.146	.154	.157	3.71	3.91	3.99
Overall Length	D	.189	.193	.197	4.80	4.90	5.00
Chamfer Distance	h	.010	.015	.020	0.25	0.38	0.51
Foot Length	L	.019	.025	.030	0.48	0.62	0.76
Foot Angle	f	0	4	8	0	4	8
Lead Thickness	С	.008	.009	.010	0.20	0.23	0.25
Lead Width	В	.013	.017	.020	0.33	0.42	0.51
Mold Draft Angle Top	α	0	12	15	0	12	15
Mold Draft Angle Bottom	β	0	12	15	0	12	15

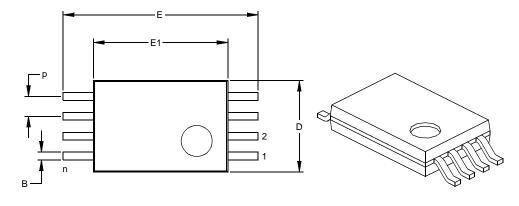
* Controlling Parameter § Significant Characteristic

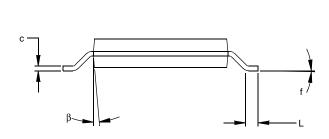
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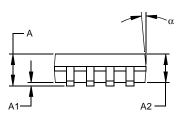
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side.

JEDEC Equivalent: MS-012 Drawing No. C04-057

8-Lead Plastic Thin Shrink Small Outline (ST) – 4.4 mm (TSSOP)







	Units		INCHES		Ν	1ILLIMETERS	S*
Dimensi	on Limits	MIN	NOM	MAX	MIN	NOM	MAX
Number of Pins	n		8			8	
Pitch	р		.026			0.65	
Overall Height	А			.043			1.10
Molded Package Thickness	A2	.033	.035	.037	0.85	0.90	0.95
Standoff §	A1	.002	.004	.006	0.05	0.10	0.15
Overall Width	Е	.246	.251	.256	6.25	6.38	6.50
Molded Package Width	E1	.169	.173	.177	4.30	4.40	4.50
Molded Package Length	D	.114	.118	.122	2.90	3.00	3.10
Foot Length	L	.020	.024	.028	0.50	0.60	0.70
Foot Angle	f	0	4	8	0	4	8
Lead Thickness	С	.004	.006	.008	0.09	0.15	0.20
Lead Width	В	.007	.010	.012	0.19	0.25	0.30
Mold Draft Angle Top	α	0	5	10	0	5	10
Mold Draft Angle Bottom	β	0	5	10	0	5	10

* Controlling Parameter

§ Significant Characteristic

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .005" (0.127mm) per side. JEDEC Equivalent: MO-153 Drawing No. C04-086

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PART NO.	<u>x /xx</u>		Exa	amples:
Device	25AA640T: 64K bit 1.8 (Tape and 25AA640X: 64K bit 1.8 in alternate 25AA640XT: 64K bit 1.8 in alternate 25LC640C: 64K bit 2.5 (Tape and 25LC640XT: 64K bit 2.5 in alternate 25LC640XT: 64K bit 2.5	V SPI Serial EEPROM V SPI Serial EEPROM Reel) V SPI Serial EEPROM e pinout (ST only) V SPI Serial EEPROM V SPI Serial EEPROM V SPI Serial EEPROM Reel) V SPI Serial EEPROM e pinout (ST only)	a) b) c) a) b) c)	25AA640-I/SN: Industrial Temp., SOIC package 25AA640T-I/SN: Tape and Reel, Industrial Temp., SOIC package 25AA640-I/ST: Industrial Temp., TSSOP package 25LC640-I/SN: Industrial Temp., SOIC package 25LC640T-I/SN: Tape and Reel, Industrial Temp., SOIC package 25LC640X-I/ST: Alternate Pinout, Industrial Temp., TSSOP package
Temperature Range	$I = -40^{\circ}C \text{ to } +8$ $E = -40^{\circ}C \text{ to } +1$			
Package	SN = Plastic SO	P (300 mil Body), 8-lead IIC (150 mil Body), 8-lead SOP (4.4 mm Body), 8-lead		

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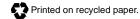
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